Notice of References Cited Application/Control No. 10/532,023 Examiner Clark F. Dexter Applicant(s)/Patent Under Reexamination MAEKAWA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0154456	08-2004	Wakayama et al.	83/880
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